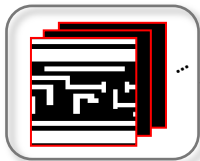
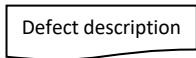


Input: many-layer layout pattern

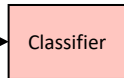
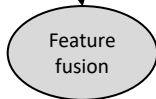
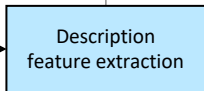
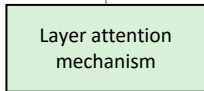
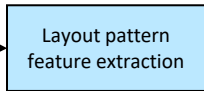


Visual information

Input: defect type



Question



Output: critical or not

